

<b>FORM PTO-1449 U.S. Department of Commerce</b> <b>Patent and Trademark Office</b>  <b>List of Documents Cited by Applicant</b>		Application No.:	10/615,842
		Filing Date:	July 10, 2003
		First Named Inventor:	Soojin Oh
		Group:	1753
		Examiner:	Phasge, Arun S.
		Attorney Docket No.:	421/170/8/2 CIP

#### U.S. PATENT DOCUMENTS

Examiner Initial	Cite No.	Document Number	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, where relevant passages or relevant figures appear

#### FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number (country code, no., kind code (if known))	Publication Date	Name of Patentee or Applicant	Pages, columns, lines where relevant passages appear	T

#### OTHER DOCUMENTS

Examiner Initials	Cite No.	Include Author (in CAPITAL LETTERS), Title, Journal, Date, Pertinent Pages, Etc.	T
<i>Arf</i>	1.	International Preliminary Report for PCT/US2004/020150 dated April 6, 2006.	

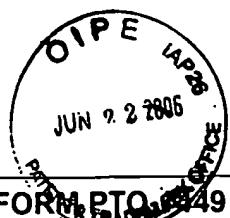
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FORM PTO-149 U.S. Department of Commerce  
Patent and Trademark Office

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<i>Asp</i>	1.	International Preliminary Report for PCT/US2004/020150 dated April 6, 2006.	

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<i>Asf</i>	1.	2003/0102222	06/05/2003	Zhou et al.	<i>      </i>

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<i>Asf</i>	1.	International Search Report for PCT/US04/20150 dated March 10, 2006.	

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<p>Substitute for form 1449A/PTO &amp; 1449B/PTO</p> <p><b>THIRD INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b></p> <p><i>(Use as many sheets as necessary)</i></p> <p>Sheet <u>1</u> of <u>1</u></p>		<b>Complete if Known</b>	
		<b>Application Number</b>	10/615,842
		<b>Filing Date</b>	July 10, 2003
		<b>First Named Inventor</b>	Soojin Oh et al.
		<b>Examiner Name</b>	Brian L. Mutschler
		<b>Attorney Docket Number</b>	032566-066

<b>NON-PATENT LITERATURE DOCUMENTS</b>	
Examiner Initials	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
<i>ASL</i>	B. GAO et al., "Fabrication and Electron Field Emission Properties of Carbon Nanotube Films by Electrophoretic Deposition", <i>Advanced Materials</i> , Vol. 13, Issue 23, pp. 1770-1773, published online November 23, 2001.

Examiner Signature	aphase	Date Considered	1/17/07
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Substitute for Form 1449A/PTO & 1449B/PTO				<b>Complete if Known</b>	
<b>SECOND INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>				<b>Application Number</b>	10/615,842
(use as many sheets as necessary)				<b>Filing Date</b>	July 10, 2003
				<b>First Named Inventor</b>	Soojin Oh et al.
				<b>Examiner Name</b>	Brian L. Mutschler
				<b>Attorney Docket Number</b>	032566-066
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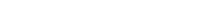
NON-PATENT LITERATURE DOCUMENTS	
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<i>Aef</i>	A. M. AFFOUNE et al., "Electrophoretic Deposition of Nanosized Diamond Particles", <i>Langmuir</i> , Vol. 17, No. 2, 2001. pp. 547-551.

Examiner Signature	<i>aphaen</i>	Date Considered		11	17	07
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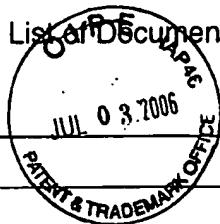
Substitute for form 1449A/PTO & 1449B/PTO				Complete if Known	
<b>FIRST</b> <b>INFORMATION DISCLOSURE</b> <b>STATEMENT BY APPLICANT</b> <small>(use as many sheets as necessary)</small>				Application Number	10/615,842
				Filing Date	July 10, 2003
				First Named Inventor	Soojin OH et al.
				Examiner Name	Unassigned
Sheet	1	of	1	Attorney Docket Number	032566-066

NON-PATENT LITERATURE DOCUMENTS	
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<i>CBF</i>	Bower, Chris et al., "Plasma-induced alignment of carbon nanotubes", Applied Physics Letters, Vol. 77, No., 6, Pages 830-832; August 7, 2000.
<i>CBF</i>	Journet, C. et al., "Large-scale production single-walled carbon nanotubes by electric-arc technique", Nature, Vol. 388, pages 757-760; August 1997.

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<i>AS</i>	1.	3,037,923	06/05/1962	Gnau	
	2.	5,906,721	05/25/1999	Bojkov et al.	
	3.	6,342,755	01/29/2002	Russ et al.	
	4.	6,616,497	09/09/2003	Choi et al.	
	5.	6,652,967	11/25/2003	Yadav et al.	
	6.	6,787,122	09/07/2004	Zhou	
	7.	6,824,755	11/30/2004	Colbert et al.	
	8.	6,850,595	02/01/2005	Zhou et al.	
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	10.	6,980,627	12/27/2005	Qiu et al.	
	11.	2003/0044519	03/06/2003	Takai	
	12.	2003/0094035	5/22/2003	Mitchell	
	13.	2003/0233871	12/25/2003	Nguyen et al.	
	14.	2003/0111946	06/19/2003	Talin et al.	
	15.	2004/0028183	02/12/2004	Lu et al.	
	16.	2004/0108298	06/10/2004	Gao	
	17.	2004/0240616	12/2/2004	Qiu et al.	
<i>AS</i>	18.	2004/0256975	12/23/2004	Gao et al.	

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<i>ASL</i>	1.	2002301700 JP	10/15/2002			
<i>ASL</i>	2.	2003075372 WO	09/12/2003			

## OTHER DOCUMENTS

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		<i>[Handwritten line]</i>	

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